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Bernd Witzigmann (*University of Kassel*)  
Johann P. Reithmaier (*University of Kassel*)  
Gadi Eisenstein (*Technion - Israel Institute of Technology*)

**TuD5: Low-Noise Characteristics on 1.3-μm-Wavelength Quantum-Dot DFB Lasers Under External Optical Feedback** (Page 111)

M. Matsuda (*Fujitsu Laboratories Ltd.*)  
N. Yasuoka (*Fujitsu Laboratories Ltd.*)  
K. Nishi (*QD Laser, Inc.*)  
K. Takemasa (*QD Laser, Inc.*)  
T. Yamamoto (*Fujitsu Laboratories Ltd.*)  
M. Sugawara (*QD Laser, Inc.*)  
Y. Arakawa (*University of Tokyo*)

**TuD6: The Gain-Enhanced Microtune: A Simple, Monolithic, Widely Tunable Diode Laser** (Page 113)

G. B. Morrison (*Freedom Photonics, LLC*)  
K. Ottosson (*Freedom Photonics, LLC*)  
J. V. Sherman (*Freedom Photonics, LLC*)  
I. Gonzalez (*Freedom Photonics, LLC*)  
J. V. Campbell (*Freedom Photonics, LLC*)  
B. Maertz (*Freedom Photonics, LLC*)  
D. Renner (*Freedom Photonics, LLC*)  
M. Mashanovitch (*Freedom Photonics, LLC*)  
L. Johansson (*Freedom Photonics, LLC*)

**Session TuP: Poster Session — 5:30 pm-7:00 pm — Canyon Room**

**TuP1: Beam Quality Improvement of Broad-Area Laser Diodes by Symmetric Facet Reflectivities** (Page 115)

Simon Rauch (*TRUMPF Laser GmbH*)  
Prasanta Modak (*TRUMPF Photonics, Inc.*)  
Carlo Holly (*TRUMPF Photonics, Inc.*)

Hagen Zimer (*TRUMPF Photonics, Inc.*)

**TuP2: Influence of Quantum Well Barrier Height on Series Resistance in GaAs-Based Broad Area Diode Lasers** (Page 117)

C. Frevert (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)  
S. Knigge (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)  
G. Erbert (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)  
F. Bugge (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)  
P. Crump (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)

**TuP3: Advancements in Broad Area InP Based High Power Lasers Operating from 1100 nm to 2100 nm** (Page 119)

Tawee Tanbun-Ek (*Coherent Inc.*)  
Zuntu Xu (*Coherent Inc.*)  
Jeff Mott (*Coherent Inc.*)

**TuP4: Mode Engineering via Waveguide Structuring** (Page 121)

Pawel Strzebonski (*University of Illinois*)  
Bradley Thompson (*University of Illinois*)  
Katherine Lakomy (*University of Illinois*)  
Paul Leisher (*Freedom Photonics*)  
Kent D. Choquette (*University of Illinois*)

**TuP5: Scattering Loss at Waveguide Facets and Implications for Laser Efficiency** (Page 123)

R. Swint (*MIT-Lincoln Laboratory*)

**TuP6: Going Beyond the Beam Quality Limit of Spectral Beam Combining** (Page 125)

Cunzhu Tong (*Chinese Academy of Sciences*)  
Fangyuan Sun (*Chinese Academy of Sciences & University of Chinese Academy of Science*)  
Yufei Zhao (*Chinese Academy of Sciences & University of Chinese Academy of Science*)  
Shili Shu (*Chinese Academy of Sciences*)  
Guanyu Hou (*Chinese Academy of Sciences & University of Chinese Academy of Science*)  
Lijie Wang (*Chinese Academy of Sciences*)  
Lijun Wang (*Chinese Academy of Sciences*)

**TuP7: Optically Pumped Polarization-Pinned GaN-Based Vertical-Cavity Surface-Emitting Lasers Using Nanoporous Distributed Bragg Reflectors** (Page 127)

Saadat M. Mishkat-Ul-Masabih (*University of New Mexico*)  
Ting S. Luk (*Sandia National Laboratories*)  
Morteza Monavarian (*University of New Mexico*)  
Daniel F. Feezell (*University of New Mexico*)

**TuP8: High Power GaN-Based Blue Superluminescent Diode Exceeding 450 mW** (Page 129)

Abdullah A. Alatawi (*King Abdullah University of Science and Technology (KAUST) & King Abdulaziz City for Science and Technology*)  
Jorge A. Holguin-Lerma (*King Abdullah University of Science & Technology (KAUST)*)  
Chao Shen (*King Abdullah University of Science and Technology (KAUST)*)  
Mohammad Khaled Shakfa (*King Abdullah University of Science and Technology (KAUST)*)  
Abdullah A. Alhamoud (*King Abdulaziz City for Science and Technology*)  
Abdulrahman M. Albadri (*King Abdulaziz City for Science and Technology*)  
Ahmed Y. Alyamani (*King Abdulaziz City for Science and Technology*)  
Tien Khee Ng (*King Abdullah University of Science & Technology (KAUST)*)  
Boon S. Ooi (*King Abdullah University of Science & Technology (KAUST)*)

**TuP9: Theoretical and Experimental Studies on Potential Fluctuation in InGaN Quantum-Well Layers** (Page 131)

T. Fujita (*Kanazawa Institute of Technology*)  
S. Sakai (*Kanazawa Institute of Technology*)  
Y. Ikeda (*Kanazawa Institute of Technology*)  
A. A. Yamaguchi (*Kanazawa Institute of Technology*)  
Y. Kanitani (*Sony Corporation*)  
S. Tomiya (*Sony Corporation*)

**TuP10: Nonpolar GaN-Based Superluminescent Diode with 2.5 GHz Modulation Bandwidth** (Page 133)

Ashwin K. Rishinaramangalam (*University of New Mexico*)  
Arman Rashidi (*University of New Mexico*)  
Saadat Mishkat Ul Masabih (*University of New Mexico*)  
Andrew A. Aragon (*University of New Mexico*)  
Morteza Monavarian (*University of New Mexico*)  
Changmin Lee (*University of California, Santa Barbara*)  
Steven P. DenBaars (*University of California, Santa Barbara*)  
Daniel F. Feezell (*University of New Mexico*)

**TuP11: Determination of Deformation Potentials in InGaN Alloy Material for Theoretical Prediction of Optical Gain Characteristics in Semipolar and Nonpolar InGaN Quantum Wells Laser Diodes** (Page 135)

Shigeta Sakai (*Kanazawa Institute of Technology*)  
Kazunobu Kojima (*Tohoku University*)  
Shigefusa F. Chichibu (*Tohoku University*)  
Atsushi A. Yamaguchi (*Kanazawa Institute of Technology*)

**TuP12: Physical Properties of 1.3 μm InAs-Based Quantum Dot Laser on Silicon** (Page 137)

Igor P. Marko (*University of Surrey*)  
Aidas Baltusis (*University of Surrey*)  
Alf R. Adams (*University of Surrey*)  
Daehwan Jung (*University of California, Santa Barbara*)  
Justin C. Norman (*University of California, Santa Barbara*)  
John E. Bowers (*University of California, Santa Barbara*)  
Stephen J. Sweeney (*University of Surrey*)

**TuP13: Dynamic Properties of Monolithic 1.3 μm InAs/GaAs Quantum Dot Lasers on Silicon** (Page 139)

Constanze Hantschmann (*University of Cambridge*)  
Peter P. Vasil'ev (*University of Cambridge & PN Lebedev Physical Institute*)  
Siming M. Chen (*University College London*)  
Mengya Liao (*University College London*)  
Alwyn J. Seeds (*University College London*)  
Huiyun Liu (*University College London*)  
Richard V. Penty (*University of Cambridge*)  
Ian H. White (*University of Cambridge*)

**TuP14: On the Relationship Between Electrical and Electro-Optical Characteristics in 1.55 μm Quantum Dot Lasers** (Page 141)

V. Mikhelashvili (*Technion - Israel Institute of Technology*)  
O. Eyal (*Technion - Israel Institute of Technology*)  
S. Ghosh (*Technion - Israel Institute of Technology*)  
I. Khanonkin (*Technion - Israel Institute of Technology*)

S. Banyoudeh (*University of Kassel*)  
V. Sichkovskyi (*University of Kassel*)  
Johann Peter Reithmaier (*University of Kassel*)  
Gadi Eisenstein (*Technion - Israel Institute of Technology*)

### TuP15: Carrier Dynamics in a 1.55 μm Tunneling Injection Quantum Dot Semiconductor Optical Amplifier (Page 143)

Igor Khanonkin (*Technion - Israel Institute of Technology*)  
Michael Lorke (*University of Bremen*)  
Stephan Michael (*University of Bremen*)  
Akhilesh Kumar Mishra (*Technion - Israel Institute of Technology & Nanyang Technological University*)  
Johann Peter Reithmaier (*Kassel University*)  
Frank Jahnke (*University of Bremen*)  
Gadi Eisenstein (*Technion - Israel Institute of Technology*)

### TuP16: Quantum Dot Frequency Comb Laser Stabilization (Page 145)

Dominik Auth (*Technische Universität Darmstadt*)  
Sebastian Stutz (*Technische Universität Darmstadt*)  
Christoph Weber (*Technische Universität Darmstadt*)  
Oleg Nikiforov (*Technische Universität Darmstadt*)  
Ricardo Rosales (*Technische Universität Berlin*)  
Thomas Walther (*Technische Universität Darmstadt*)  
Luke F. Lester (*Virginia Polytechnic Institute and State University*)  
Stefan Breuer (*Technische Universität Darmstadt*)

### TuP17: Continuous-Wave Lasing of 1.3-μm Quantum-Dot Photonic-Crystal Surface-Emitting Lasers (Page 147)

Ming-Yang Hsu (*National Chiao Tung University*)  
Gray Lin (*National Chiao Tung University*)  
Po-Chou Pan (*National Chiao Tung University*)  
Yu-Chen Chen (*National Chiao Tung University*)

### TuP18: Mode Locking Stability Regimes in Tapered Quantum Dot Lasers (Page 149)

Paolo Bardella (*Politecnico di Torino*)  
Mattia Rossetti (*Politecnico di Torino*)  
Lukas Drzewietzki (*Technische Universität Darmstadt*)  
Christoph Weber (*Technische Universität Darmstadt*)  
Michel Krakowski (*III-V Labs*)  
Igor Krestnikov (*Innolume GmbH*)  
Stefan Breuer (*Technische Universität Darmstadt*)

### TuP19: Demonstration of Switchable All-Optical Flip-Flop and Inverter Operations in Semiconductor Microring Laser (Page 151)

Ryosuke Aoki (*Yokohama National University*)  
Naoki Kobayashi (*Yokohama National University*)  
Yusaku Kawamura (*Yokohama National University*)  
Taro Arakawa (*Yokohama National University*)  
Yasuo Kokubun (*Yokohama National University*)

### TuP20: Energy Cost Analysis of Ridge-Waveguide Type Membrane Distributed-Reflector Lasers for On-Chip Application (Page 153)

Nagisa Nakamura (*Tokyo Institute of Technology*)  
Takamasa Yoshida (*Tokyo Institute of Technology*)  
Weicheng Fang (*Tokyo Institute of Technology*)  
Tomohiro Amemiya (*Tokyo Institute of Technology*)  
Nobuhiko Nishiyama (*Tokyo Institute of Technology*)  
Shigehisa Arai (*Tokyo Institute of Technology*)

**TuP21: The COMBO DBR: Comb-Optimized DBR Laser for Versatile Design** (Page 155)

G. B. Morrison (*Freedom Photonics LLC*)  
J. Sherman (*Freedom Photonics LLC*)  
I. Gonzalez (*Freedom Photonics LLC*)  
K. Ottosson (*Freedom Photonics LLC*)  
J. Campbell (*Freedom Photonics LLC*)  
S. Estrella (*Freedom Photonics LLC*)  
R. Moireira (*Freedom Photonics LLC*)  
P. Leisher (*Freedom Photonics LLC*)  
D. Renner (*Freedom Photonics LLC*)  
L. Johansson (*Freedom Photonics LLC*)  
M. Mashanovitch (*Freedom Photonics LLC*)

**TuP22: 1.5 μm GaInAsP High Mesa Laser Diode on Directly Bonded InP/Si Substrate** (Page 157)

Gandhi Kallarasan Periyanayagam (*Sophia University*)  
Kzuki Uchida (*Sophia University*)  
Hirokazu Sugiyama (*Sophia University*)  
Xu Han (*Sophia University*)  
Natsuki Hayasaka (*Sophia University*)  
Masaki Aikawa (*Sophia University*)  
Hiromu Yada (*Sophia University*)  
Kazuhiko Shimomura (*Sophia University*)

**TuP23: Multi-Channel Interference Widely Tunable Laser Integrated with Semiconductor Optical Amplifier through Deeply Etched Slot** (Page 159)

Chun Jiang (*Huazhong University of Science and Technology*)  
Quanan Chen (*Huazhong University of Science and Technology*)  
Qiaoyin Lu (*Huazhong University of Science and Technology*)  
Weihua Guo (*Huazhong University of Science and Technology*)

**TuP24: Extremely High Dynamic Outer Extinction Ratio (9.7 dB) of 56-Gb/s PAM-4 with EA-DFB Lasers by Optical Orthogonal Polarization-Multiplexing** (Page 161)

Kouji Nakahara (*Oclaro Japan, Inc.*)  
Riu Hirai (*Hitachi Ltd.*)  
Nobuhiko Kikuchi (*Hitachi Ltd.*)  
Koichi R. Tamura (*Oclaro Japan, Inc.*)  
Shigehisa Tanaka (*Oclaro Japan, Inc.*)

**TuP25: A High Performance EML TOSA Employing FPC Interface for 53 GBAud PAM4** (Page 163)

Mizuki Shirao (*Mitsubishi Electric Corporation*)  
Hayato Sano (*Mitsubishi Electric Corporation*)  
Seiki Nakamura (*Mitsubishi Electric Corporation*)  
Asami Uchiyama (*Mitsubishi Electric Corporation*)  
Yudai Imai (*Mitsubishi Electric Corporation*)

Kiyotomo Hasegawa (*Mitsubishi Electric Corporation*)

**TuP26: In-Line Non-Destructive Characterisation Method for Photonic Crystal Surface Emitting Lasers** (Page 165)

Ben C. King (*University of Glasgow*)  
Richard J. E. Taylor (*University of Glasgow*)  
Pavlo Ivanov (*University of Glasgow*)  
Iain Butler (*University of Glasgow*)  
Timothy S. Roberts (*University of Sheffield*)  
David T. D. Childs (*University of Glasgow*)  
Richard A. Hogg (*University of Glasgow*)

**TuP27: Room Temperature Photonic Crystal Surface Emitting Laser with Synthesized Monolayer Tungsten Disulfide** (Page 167)

Xiaochen Ge (*University of Texas at Arlington*)  
Momchil Minkov (*Stanford University*)  
Tanushree Choudhury (*Pennsylvania State University*)  
Mikhail Chubarov (*Pennsylvania State University*)  
Shanhui Fan (*Stanford University*)  
Joan Redwing (*Pennsylvania State University*)  
Xiuling Li (*University of Illinois Urbana-Champaign*)  
Weidong Zhou (*University of Texas at Arlington*)

**TuP28: Modelling and Device Simulation of Photonic Crystal Surface Emitting Lasers Based on Modal Index Analysis** (Page 169)

Guangrui Li (*University of Glasgow*)  
Jayanta Sarma (*University of Glasgow*)  
Iain Butler (*University of Glasgow*)  
Richard J. E. Taylor (*University of Glasgow*)  
David T. D. Childs (*University of Glasgow*)  
Richard A. Hogg (*University of Glasgow*)

**TuP29: Random Bit Generation in Dual Transverse Mode Microlaser without Optical Injection or Feedback** (Page 171)

Jin-Long Xiao (*University of Chinese Academy of Sciences, Chinese Academy of Sciences*)  
Chun-Guang Ma (*University of Chinese Academy of Sciences, Chinese Academy of Sciences*)  
Zhi-Xiong Xiao (*University of Chinese Academy of Sciences, Chinese Academy of Sciences*)  
Yue-De Yang (*University of Chinese Academy of Sciences, Chinese Academy of Sciences*)  
Yong-Zhen Huang (*University of Chinese Academy of Sciences, Chinese Academy of Sciences*)

**TuP30: Waveguide Coupling of Wavelength-Scale Capsule-Shaped Metal-Clad Laser** (Page 173)

Yi Xiao (*University of Tokyo*)  
Mitsuhiko Watanabe (*University of Tokyo*)  
Yuguang Wang (*University of Tokyo*)  
Takuo Tanemura (*University of Tokyo*)  
Yoshiaki Nakano (*University of Tokyo*)

**TuP31: Photonic Crystal Surface Emitting Lasers with Novel Transparent Cladding Layers** (Page 175)

Shen-Che Huang (*National Chiao Tung University*)  
Kuo-Bin Hong (*National Chiao Tung University*)  
Han-Lun Chiu (*National Chiao Tung University*)  
Tien-Chang Lu (*National Chiao Tung University*)

**TuP32: Cantilever-Based Microring Lasers** (Page 177)

Taojie Zhou (*Chinese University of Hong Kong*)  
Xiu Liu (*Chinese University of Hong Kong*)  
Boyuan Xiang (*Chinese University of Hong Kong*)  
Xuan Fang (*Chinese University of Hong Kong*)  
Zhaoyu Zhang (*Chinese University of Hong Kong*)

**TuP33: Gain Lever Effect in a 2 μm InGaSb/AlGaAsSb Quantum Well Laser**

X. Li (*Nanyang Technological University*)  
H. Wang (*Nanyang Technological University*)  
Z. L. Qiao (*Nanyang Technological University*)  
X. Guo (*Nanyang Technological University*)  
W. J. Wang (*Nanyang Technological University*)  
J. X. Sia (*Nanyang Technological University*)  
C. Y. Liu (*Nanyang Technological University*)

**TuP34: Efficiency Limiting Mechanisms in 1.2-1.3 μm GaInAs/GaAsSb 'W' Lasers** (Page 181)

Timothy D. Eales (*University of Surrey*)  
Igor P. Marko (*University of Surrey*)  
Chris Kemp (*University of Surrey*)  
Christian Fuchs (*Philipps-Universität Marburg*)  
Wolfgang Stoltz (*Philipps-Universität Marburg*)  
Stephen J. Sweeney (*University of Surrey*)

**TuP35: Evaluation of Dilute Bismide Materials for Mid-IR Applications** (Page 183)

J. Hader (*Nonlinear Control Strategies Inc. & University of Arizona*)  
S. C. Badescu (*Air Force Research Laboratory*)  
L. C. Bannow (*Philipps-Universität Marburg*)  
J. V. Moloney (*Nonlinear Control Strategies Inc. & University of Arizona*)  
S. R. Johnson (*Arizona State University*)  
S. W. Koch (*Philipps-Universität Marburg*)

**TuP36: MEMS Tunable Littman-Metcalf Diode Laser at 2.2 μm for Rapid Broadband Spectroscopy in Aqueous Solutions** (Page 185)

N. Torcheboeuf (*Centre Suisse d'Electronique et de Microtechnique SA (CSEM)*)  
S. Droz (*Centre Suisse d'Electronique et de Microtechnique SA (CSEM)*)  
I. Šimonytė (*UAB Brolis Semiconductors*)  
A. Miasojedovas (*Brolis Semiconductors UAB*)  
A. Trinkūnas (*Brolis Semiconductors UAB*)  
K. Vizbaras (*Brolis Semiconductors UAB*)  
A. Vizbaras (*Brolis Semiconductors UAB*)  
D. L. Boiko (*Centre Suisse d'Electronique et de Microtechnique SA (CSEM)*)

**TuP37: Controlling the Quantum Cascade Laser Frequency Comb via Risken-Nummedal-Graham-Haken Instability** (Page 187)

A. A. Antonov (*Institute for Physics of Microstructures Russian Academy of Sciences*)  
D. I. Kuritsyn (*Institute for Physics of Microstructures Russian Academy of Sciences*)  
A. Gajic (*University of Belgrade & Regulatory Agency for Electronic Communications and Postal Services*)  
E. E. Orlova (*Institute for Physics of Microstructures Russian Academy of Sciences*)

N. Vukovic (*University of Belgrade*)

J. Radovanovic (*University of Belgrade*)

V. V. Vaks (*Institute for Physics of Microstructures Russian Academy of Sciences*)

D. L. Boiko (*Centre Suisse d'Electronique et de Microtechnique SA (CSEM)*)

**TuP38: Electrically-Injected VCSELs with a Composite Monolithic High Contrast Grating and Distributed Bragg Reflector Coupling Mirror** (Page 189)

Marcin Gębski (*Technische Universität Berlin & Lodz University of Technology*)

Tomasz Czyszanowski (*Lodz University of Technology*)

James A. Lott (*Technische Universität Berlin*)

**TuP39: Lasing Action in GaN-Based VCSELs with Top High-Contrast Grating Reflectors** (Page 191)

Tsu-Chi Chang (*National Chiao Tung University*)

Shuo-Yi Kuo (*National Chiao Tung University*)

Ehsan Hashemi (*Chalmers University of Technology*)

Åsa Haglund (*Chalmers University of Technology*)

Tien-Chang Lu (*National Chiao Tung University*)

**TuP40: Large-Signal Circuit Model for Datacom VCSELs** (Page 193)

Alexander Grabowski (*Chalmers University of Technology*)

Johan Gustavsson (*Chalmers University of Technology*)

Zhongxia Simon He (*Chalmers University of Technology*)

Anders Larsson (*Chalmers University of Technology*)

**TuP41: Simultaneous Use of Spontaneous Emission Light in VCSEL for Improving Efficiency of Optical Wireless Power Transmission** (Page 195)

Tomoyuki Miyamoto (*Tokyo Institute of Technology*)

Yoshihisa Suda (*Tokyo Institute of Technology*)

**TuP42: Beam Quality Factor Analysis for Coherently-Coupled Vertically-Emitting Laser Arrays** (Page 197)

James J. Raftery, Jr. (*United States Military Academy*)

Joshua B. Groen (*United States Military Academy*)

Kirk A. Ingold (*United States Military Academy*)

**TuP43: Physics of Widely Tunable VCSELs with Coupled Cavities** (Page 199)

Kevin T. Cook (*University of California, Berkeley*)

Pengfei Qiao (*University of California, Berkeley*)

Jipeng Qi (*University of California, Berkeley*)

Larry A. Coldren (*University of California, Santa Barbara*)

Connie J. Chang-Hasnain (*University of California, Berkeley*)

**TuP44: Microscopic Many-Body Model for Mode-Locked and Multi-Wavelength Operation in Vertical External-Cavity Surface-Emitting Lasers** (Page 201)

Isak Kilen (*University of Arizona*)

Stephan W. Koch (*Philipps-Universität Marburg*)

Jörg Hader (*University of Arizona*)

Jerome V. Moloney (*University of Arizona*)

**TuP45: VECSEL-Based Offset-Free Frequency Comb in the MIR** (Page 203)

Robert Rockmore (*University of Arizona*)

Alexandre Laurain (*University of Arizona*)

Jerome V. Moloney (*University of Arizona*)

R. Jason Jones (*University of Arizona*)

**TuP46: Watt-Level High Order Hermite-Gaussian and Laguerre-Gaussian Beams from Vertical External Cavity Surface Emitting Lasers** (Page 205)

Michal L. Lukowski (*University of Arizona & TPhotonics, Inc.*)

Jason T. Meyer (*University of Arizona*)

Chris Hessenius (*University of Arizona & TPhotonics, Inc.*)

Ewan M. Wright (*University of Arizona*)

Mahmoud Fallahi (*University of Arizona*)

**TuP47: A Laser that Optomechanically Cools Itself**

Justin M. Foley (*National Institute of Standards and Technology*)

Adarsh V. Ganesan (*National Institute of Standards and Technology*)

John R. Lawall (*National Institute of Standards and Technology*)

Weijian Yang (*University of California at Davis*)

Chris Chase (*Bandwidth10, Inc.*)

**TuP48: A New Method to Evaluate the Degree of Potential Fluctuation in InGaN Quantum-Well Laser Diodes by Optical-Pump Stimulated-Emission Measurements** (Page 209)

I. Oshima (*Kanazawa Institute of Technology*)

Y. Ikeda (*Kanazawa Institute of Technology*)

S. Sakai (*Kanazawa Institute of Technology*)

A. A. Yamaguchi (*Kanazawa Institute of Technology*)

Y. Kanitani (*Sony Corporation*)

S. Tomiya (*Sony Corporation*)

**TuP49: High Speed Wavelength Tuning of MEMS VCSEL with Advanced Voltage Drive Technique** (Page 211)

Shunya Inoue (*Tokyo Institute of Technology*)

Shun Nishimura (*Tokyo Institute of Technology*)

Masanori Nakahama (*Tokyo Institute of Technology*)

Akihiro Matsutani (*Tokyo Institute of Technology*)

Fumio Koyama (*Tokyo Institute of Technology*)

**Session WA: Plenary III — 8:30 am-9:45 am — Mesa Ballroom****WA1: Opportunities in Semiconductor Laser Technology for Meeting the Requirements of Future High Energy Laser Missions** (Page NA)

Paul Leisher (*Lawrence Livermore National Laboratory*)

**WA2: Analysis and Design of Semiconductor Lasers Using Strain** (Page NA)

Alf Adams (*University of Surrey*)

**Session WB: Novel Lasers and Materials — 10:15 am-12:15 pm — Mesa Ballroom****WB1: Non-Reciprocal Lasing from Topological Cavities** (Page NA)

Boubacar Kante (*University of California San Diego*)

**WB2: 7W CW Operation of Double-Lattice Photonic-Crystal Lasers** (Page 213)

Menaka De Zoysa (*Kyoto University*)

Masahiro Yoshida (*Kyoto University*)  
Kenji Ishizaki (*Kyoto University*)  
Bong-Shik Song (*Kyoto University & Sungkyunkwan University*)  
Yoshinori Tanaka (*Kyoto University*)  
Ranko Hatsuda (*Kyoto University*)  
Shin Fukuwara (*Kyoto University*)  
Susumu Noda (*Kyoto University*)

**WB3: GaInAsP Photonic Crystal Bandedge Laser with High Ion Sensitivity** (Page 215)

Keisuke Watanabe (*Yokohama National University*)  
Toshihiko Baba (*Yokohama National University*)

**WB4: Nanoscale III-V Light Emitting Diode with Antenna-Enhanced 250 Picosecond Spontaneous Emission Lifetime** (Page 217)

Seth A. Fortuna (*University of California, Berkeley*)  
Christopher Heidelberger (*Massachusetts Institute of Technology*)  
Eli Yablonovitch (*University of California, Berkeley*)  
Eugene A. Fitzgerald (*Massachusetts Institute of Technology*)  
Ming C. Wu (*University of California, Berkeley*)

**WB5: Iontronic Control of GaInAsP Photonic Crystal Nanolaser** (Page 219)

Yoshito Saito (*Yokohama National University*)  
Takumi Watanabe (*Yokohama National University*)  
Keisuke Watanabe (*Yokohama National University*)  
Yoshiaki Nishijima (*Yokohama National University*)  
Toshihiko Baba (*Yokohama National University*)

**WB6: Low-Threshold Operation of GaAs-Based (Gain)As/Ga(AsSb)/(Gain)As "W"-Quantum Well Lasers Emitting at 1.3 μm** (Page 221)

C. Fuchs (*Philipps-Universität Marburg*)  
P. Ludewig (*NAsPIII/V GmbH*)  
A. Brüggemann (*Philipps-Universität Marburg*)  
A. Ruiz Perez (*NAsPIII/V GmbH*)  
M. J. Weseloh (*Philipps-Universität Marburg*)  
S. Reinhard (*Philipps-Universität Marburg*)  
J. Hader (*Nonlinear Control Strategies, Inc. & University of Arizona*)  
J. V. Moloney (*Nonlinear Control Strategies, Inc. & University of Arizona*)  
A. Bäumner (*Philipps-Universität Marburg*)  
S. W. Koch (*Philipps-Universität Marburg*)  
W. Stolz (*Philipps-Universität Marburg*)

**WB7: The Nature of Auger Recombination in Type-I Quantum Well Lasers Operating in the Near- and Mid-Infrared** (Page 223)

Timothy Eales (*University of Surrey*)  
Igor P. Marko (*University of Surrey*)  
Barnabas A. Ikyo (*University of Surrey*)  
Alf R. Adams (*University of Surrey*)  
Alexander Andrejew (*Technische Universität München*)  
Kristijonas Vizbaras (*Technische Universität München*)  
Markus-C. Amann (*Technische Universität München*)  
Leon Shterengas (*State University of New York at Stony Brook*)  
Stephen J. Sweeney (*University of Surrey*)

## **Session WC: High Power Lasers — 1:30 pm-3:30 pm — Mesa Ballroom**

### **WC1: High Pulse Power Wavelength Stabilized Laser Diodes for Automotive LiDAR** (Page 225)

A. Knigge (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)  
A. Klehr (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)  
H. Wenzel (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)  
A. Zeghuzzi (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)  
J. Fricke (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)  
A. Maaßdorf (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)  
A. Liero (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)  
G. Tränkle (*Ferdinand-Braun-Institut, Leibniz-Institut für Höchstfrequenztechnik*)

### **WC2: Tapered Monolithic Mode-Locked Laser Diode with 200 PJ Pulse Energy for Space Applications** (Page 227)

M. Krakowski (*III-V Lab*)  
P. Resneau (*III-V Lab*)  
M. Garcia (*III-V Lab*)  
E. Vinet (*III-V Lab*)  
Y. Robert (*III-V Lab*)  
C. Theveneau (*III-V Lab*)  
M. Lecomte (*III-V Lab*)  
O. Parillaud (*III-V Lab*)  
B. Gerard (*III-V Lab*)  
S. Kundermann (*Centre Suisse d'Electronique et de Microtechnique SA (CSEM)*)  
N. Torcheboeuf (*Centre Suisse d'Electronique et de Microtechnique SA (CSEM)*)  
D. L. Boiko (*Centre Suisse d'Electronique et de Microtechnique SA (CSEM)*)

### **WC3: High Power and High Beam Quality VCSEL Amplifier** (Page 229)

Zeuku Ho (*Tokyo Institute of Technology*)  
Junichiro Hayakawa (*Fuji Xerox Co., Ltd.*)  
Keisuke Shimura (*Tokyo Institute of Technology*)  
Keisuke Kondo (*Tokyo Institute of Technology*)  
Xiaodong Gu (*Tokyo Institute of Technology*)  
Akihiro Matsutani (*Tokyo Institute of Technology*)  
Akemi Murakami (*Fuji Xerox Co., Ltd.*)  
Fumio Koyama (*Tokyo Institute of Technology*)

### **WC4: Reliable 2 W DBR-Tapered Diode Lasers Lasing at 1180 nm Based on Highly Strained Quantum Wells** (Page 231)

K. Paschke (*Ferdinand-Braun-Institut Leibniz-Institut für Höchstfrequenztechnik*)  
G. Blume (*Ferdinand-Braun-Institut Leibniz-Institut für Höchstfrequenztechnik*)  
A. Ginolas (*Ferdinand-Braun-Institut Leibniz-Institut für Höchstfrequenztechnik*)  
D. Feise (*Ferdinand-Braun-Institut Leibniz-Institut für Höchstfrequenztechnik*)  
W. John (*Ferdinand-Braun-Institut Leibniz-Institut für Höchstfrequenztechnik*)  
N. Werner (*Ferdinand-Braun-Institut Leibniz-Institut für Höchstfrequenztechnik*)  
F. Bugge (*Ferdinand-Braun-Institut Leibniz-Institut für Höchstfrequenztechnik*)  
B. Sumpf (*Ferdinand-Braun-Institut Leibniz-Institut für Höchstfrequenztechnik*)

### **WC5: Failure Mode and Lifetime Analysis of 9xx nm High Power Broad Stripe Laser Diodes** (Page 233)

Y. Yamagata (*Fujikura Ltd.*)  
S. Sato (*Optoenergy, Inc.*)  
Y. Yamada (*Optoenergy Inc.*)  
M. Yamaguchi (*Fujikura Ltd.*)

**WC6: Flared Oscillator Waveguide Diodes (FLOW-Diodes) Produce Record-High Single-Wavelength Fiber-Coupled Power** (Page 235)

M. Kanskar (*nLIGHT, Inc.*)  
L. Bao (*nLIGHT, Inc.*)  
Z. Chen (*nLIGHT, Inc.*)  
D. Dawson (*nLIGHT, Inc.*)  
M. DeVito (*nLIGHT, Inc.*)  
M. Grimshaw (*nLIGHT, Inc.*)  
X. Guan (*nLIGHT, Inc.*)  
M. Hemenway (*nLIGHT, Inc.*)  
Thomas Prunty (*nLIGHT, Inc.*)  
W. Urbanek (*nLIGHT, Inc.*)  
S. Zhang (*nLIGHT, Inc.*)

**WC7: High Power, 14xx-nm Eye-Safe, Epitaxially Stacked Pulse Laser for Detection and Ranging Applications** (Page 237)

Yasutaka Higa (*Furukawa Electric Co., Ltd.*)  
Masahiro Yoshida (*Furukawa Electric Co., Ltd.*)  
Nobuhiko Nishiyama (*Tokyo Institute of Technology*)  
Yasuyuki Miyamoto (*Tokyo Institute of Technology*)  
Nobuyuki Kagi (*Furukawa Electric Co., Ltd.*)

## **Session WD: Datacom VCSELs and Post Deadline — 4:00 pm-5:45 pm — Mesa Ballroom**

### **WD1: How Ethernet Standards Shaped VCSEL Technology** (Page 239)

Jack Jewell (*GreenVCSEL*)

### **WD2: Vertical-Cavity Silicon-Integrated Lasers by Bonding and Transfer Printing** (Page 241)

E. P. Haglund (*Chalmers University of Technology*)

S. Kumari (*Ghent University*)

J. Goyvaerts (*Ghent University*)

J. S. Gustavsson (*Chalmers University of Technology*)

R. G. Baets (*Ghent University*)

G. Roelkens (*Ghent University*)

A. Larsson (*Chalmers University of Technology*)

### **WD3: Enhanced Digital Modulation of Coherent Photonic Crystal VCSEL Arrays** (Page 243)

Harshil Dave (*University of Illinois Urbana-Champaign*)

Peicheng Liao (*University of Southern California*)

Stewart T. M. Frieslie (*Freedom Photonics*)

Zihe Gao (*University of Illinois Urbana-Champaign*)

Bradley J. Thompson (*University of Illinois Urbana-Champaign*)

Alan E. Willner (*University of Southern California*)

Kent D. Choquette (*University of Illinois Urbana-Champaign*)

### **WD4: 35 GHz Bandwidth with Directly Current Modulated 980 nm Oxide Aperture Single Cavity VCSELs** (Page 245)

Nasibeh Haghghi (*Technische Universität Berlin*)

Gunter Larisch (*Technische Universität Berlin*)

Ricardo Rosales (*Technische Universität Berlin*)

Martin Zorn (*JENOPTIK Diode Lab GmbH*)

James A. Lott (*Technische Universität Berlin*)

### **PD1: Continuous Tuning of Gain Peak Linewidth Enhancement Factor from Negative to Positive with p Doping in InAs QD Laser on Si** (Page 247)

Zeyu Zhang (*University of California, Santa Barbara*)

Daehwan Jung (*University of California, Santa Barbara*)

Justin C. Norman (*University of California, Santa Barbara*)

Pari Patel (*University of California, Santa Barbara*)

Weng W. Chow (*Sandia National Laboratories*,)

John E. Bowers (*University of California, Santa Barbara*)